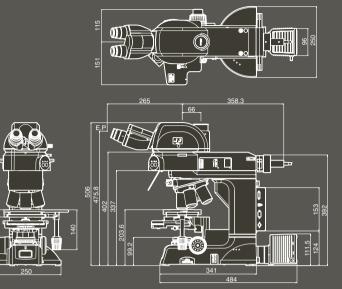
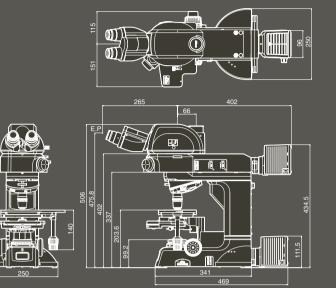


LV100DA-U



LV100DA-U+LV-TT2+LV-UEPI2A+LV-S32

LV100D-U



LV100D-U+LV-TT2+LV-UEPI2+LV-S32







LV100D-U/LV100DA-U





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TO ENSURE CORRECT USAGE, READ THE CORRESPONDING MANUALS CAREFULLY BEFORE USING THE EQUIPMENT.

ISO 14001

ISO 14001 Certi

Industrial Microscopes ECLIPSE LV100D-U/LV100DA-U/LVDIA-U







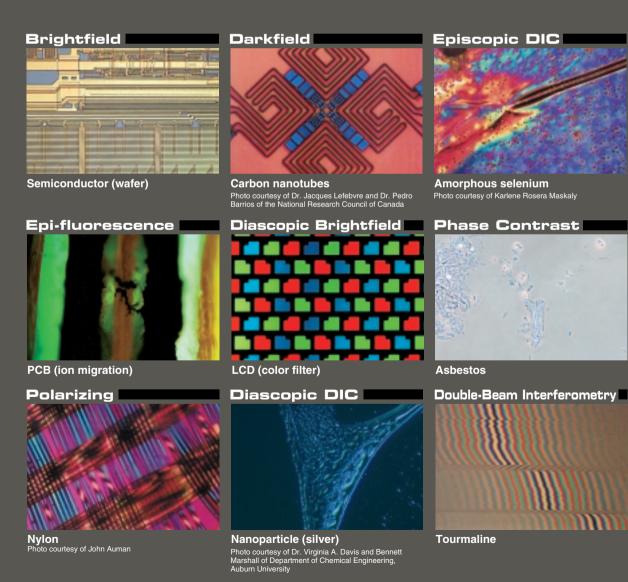


Universal Design Microscope

Versatility is Our Solution

the Visible and the Invisible

The new Eclipse LV100DA-U and LV100D-U bring together Nikon's world renowned CFI60 and CFI LU60 optical systems on one universal microscope platform! Materials ranging from thin films, plastics, fibers, nanoparticles, emulsions, to material science, metallography, FPDs and microcircuits can be easily visualized and documented with a single microscope. A true solution for both routine and R & D applications.



Universal - Nosepiece and Condenser Design - Advanced Observation Methods Microscope - Motorized and Manual

LV100D-U (Manual)





Universal Design

Enables a Wide Range of Observation Methods

These microscopes enable a wide range of observation methods by combining illuminator, nosepiece. condenser and objective lenses.

	Brightfield	Darkfield	DIC	Fluorescence	Polarizing	Phase-contrast	Double-Beam Interferometry
Episcopic	0	0	0	0	0	—	0
Diascopic	0	0	0		0	0	—

Universal Condenser Lens

LV-CUD Universal Condenser Dry

More diascopic features

Brightfield, darkfield, DIC, simple

Pol and phase contrast observation

are all possible. Simply select the

condenser position for the method

Darkfield: D-C Darkfield Ring

DIC: D-C DIC Module Dry

Phase-contrast: D-C PHModule

ou wish to use.

Universal Nosepiece

LV-NU5AI Universal Motorized Quintuple Nosepiece

No nosepiece changeover necessary

The LV100DA-U features a newly developed motorized nosepiece. In addition to brightfield and darkfield observation, the LV-NU5AI Universal Nosepiece enables a wide range of observation methods including episcopic and diascopic DIC. The LV-NCNT2 motorized nosepiece controller can be used in



combination with the LV-NU5AI on the LV100D-U.

Supports a Wide Range of Samples

Increased maximum sample height

The standard maximum specimen height is 38mm (33mm when combined with the LV-NU5AI nosepiece). Combined with a column riser, it is 73mm (or 68mm with the nosepiece), and with a combination of the LV-DIA-U DIA Base U and LV-FM FM module, specimens with a height up to 102mm (or 97mm) can be accommodated. * With diascopic illumination, the maximum specimen height depends on the focal length of the condenser used.



Without column riser

With column riser



LVDIA-U+LV-FM

Accepts various stages

In addition to the LV-S32 3x2 Stage, users can select a wide variety of stages according to their needs, including the LV-S64 6x4 Stage for larger specimens, or the LV-SRP Fine Rotating Stage for polarized light microscopy.



LV-S32 3x2 Stage

LV-S32 3x2 is a compact stage for industrial microscopes. Its triple-plate design ensures durability, stability and ease of use, even when heavy samples such as metallic materials are observed. The standard glass plate makes this stage suitable for episcopic and diascopic illumination.

> LV-S32PL ESD Plate



LV-S32SGH Slideglass Holder

Although the LV-LH50PC Precentered Lamphouse is 12V-50W, the brightness is equivalent to or higher than that of 12V-100W. The low powerconsumption halogen light source contributes to the

compact design of the microscope while also being friendly to the environment. Defocus induced by heat is substantially reduced.



50W brightor than 100

Image brightness is not determined by wattage. Nikon's new light source delivers greater brightness by optimizing the lamp filament size and improving pupil illumination fulfillment by optically expanding the size of the light source. This has resulted in a 50W light source that is brighter than a 100W lamp. With 50x or higher objectives, brightness is about 20% greater under episcopic illumination, 40-50% greater with diascopic illumination, than previous Nikon illuminators.

Clear, aberration-free images are the standard.

The LV series utilizes Nikon's world renowned CFI60 & CFI LU60 infinity optics to provide world-class optical performance, with the highest levels of resolution, contrast, and transmission and longer working distances. Clear, aberration-free images are the standard.

CFI Plan Fluor

CFI Plan Fluor objectives have high transmission throughout the entire visible spectrum including applications that require IR and UV. These objectives can be used in all transmitted light applications including brightfield, Darkfield, DIC, simple Pol and epifluorescence. They are designed for use with specimens using standard coverslips unlike the CFI LU Plan Fluor objectives, which are designed for uncovered or opaque materials. A number of these objectives have correction collars which can compensate for glass windows

up to 2mm thick with long working distances for chamber applications



CFI Plan Fluor DL/DLL

CFI Plan Fluor DL/DLL lenses provide phase contrast observation. Phase Contrast allows for observation of transparent or low contrast materials such as plastics, fibers and emulsions. They can be used for other applications such as brightfield. fluorescence

and DIC with very acceptable results. They are designed for use with coverslips.



CFI Plan Fluor DL/DLL

4

High-Intensity 12V-50W Halogen Light Source: HG Precentered Fiber Illuminator—Intensilight LV-LH50PC Precentered Lamphouse (for LV-UEPI2/LV-UEPI2A)

The use of the Intensilight precentered fiber illuminator eliminates the need for centering and focus adjustment, even after the lamp is replaced. Because the light source can be placed away from the microscope, heat and electrical noise to the microscope body is

reduced. Six levels of light intensity from 3% to 100% are available, including a built-in shutter. The lamp lasts an average of 2,000 hours, reducing replacement frequency and cost. Both manual (C-HGFI) and motorized (C-HGFIE) models are available. The C-HGFIE should be used in combination with the LV100DA-U. The motorized model can be controlled from an optional dedicated remote controller or a PC with Nikon's NIS-Elements imaging software installed. It can also be controlled directly from the microscope itself.



C-HGFIE (motorized)

CFI LU Plan Fluor

CFI LU Plan Fluor lenses have high transmittance in the ultraviolet region, making them suitable for use with many methods including episcopic/diascopic brightfield, episcopic/diascopic darkfield (only BD objective lens for episcopic darkfield), episcopic DIC, simple polarization, and epifluorescent (visible/UV) observation. They are designed for use without a coverglass.





CFI P Acromat

CFI POL Achromat lenses are strain free and designed for quantitative transmitted polarized light applications. They are designed for use with coverslipped specimens.







CFI LU Plan EPI P

CFI LU Plan EPI POL are strain free and designed for quantitative reflected and transmitted polarized light applications with materials that have no coverslip



Documentation Systems

Optimized Digital Image Capture

The motorized model LV100DA-U meets all requirements for digital imaging, analysis, Z stacks, Extended Depth of Focus (EDF) and archiving among others. Used in conjunction with the motorized universal episcopic illuminator LV-UEPI2A, digital cameras DS-Fi1 or DS-2Mv with control units DS-L2 or DS-U2, and Elements imaging software. observation methods and illumination conditions can be optimized for image capture. The LV100DA-U also supports external quantitative control, and data communication and control of the magnification information required for measurement functions and display of scale.





Camera Heads High-definition color camera head

High-speed color camera head DS-2Mv The DS-2Mv features a 2-megapixel color CCD with a high frame rate. This camera head enables the smooth display of live images and high quality still images.

Stand-alone Control Unit

The DS-L2 features a large high-definition LCD and a host of features. There is no need for a PC and monitor, which allows the system to be used with a flick of a switch.

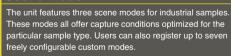
An extensive array of tool functions

Users can measure captured images and enter line contrast and other settings using the overlay. Users can also save data in image files and output measurement data.

urement and alignment is possible by standard-length calibration (up to seven types can be registered)

Users can input and display lines, comments, and other useful elements ·Straight lines (Arrows can be set.) ·Curves ·Count markers ·Text entry mposition (semitransparent image overlay for comparative purposes)

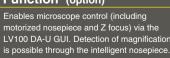
Scene mode



*See the Digital Sight series catalog for more information.



Microscope Control Function (option)







E X

. 8009 ED

BF FL1 FL2

LV100DA-U+DS-Fi1+DS-U2

PC-based Control Unit



The DS-U2 enables everything from live image display, advanced image processing, analysis to capturing on a computer. It supports a wide range of applications.

Simple connection with high-speed USB 2.0

The unit employs a USB 2.0 interface for easy connection with a PC.

Microscope Control Function

Enables microscope control (including motorized nosepiece and Z focus) via the LV PAD. Detection of magnification is possible through the intelligent nosepiece.

Elements

their intended use.

Free bundle NIS-Elements F Package

Application window

purpose at hand.

This package enables display of a scale over a live image, switching to full-screen display, and other functions. It allows the user to easily capture images with a simple intuitive control screen

Standard set

D NIS-Elements Documentation

This package provides functions for performing measurements and creating reports. Use it for general microimage capture in the industrial field Expandability is also possible by adding plug-ins, such as EDF and databases.



Option NIS-Elements Basic Research

In addition to the measurement function and reportgenerating function of NIS-Elements Documentation, this package enables automatic object measurement by creating a binary image. Expandability is also possible by adding plug-ins, such as FDF and databases

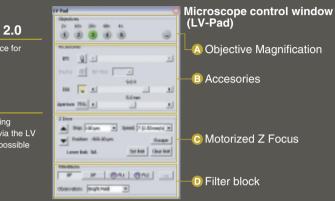
Operating environment

The following PC environment is recommended for maximizing the performance of NIS-Elements.

CPU	3.2GHz Intel [®] Pentium [®] IV processor or better
RAM	1GB or more
OS	Microsoft®Windows®XP SP2 (English version)
Hard disk space	600MB or more required for installation
Display	1280 x 1024 dots or better (TrueColor mode)

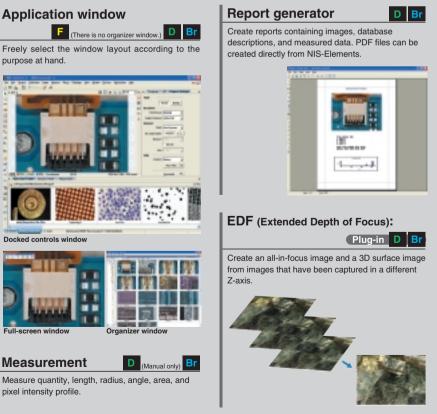
Measurement

Measure quantity, length, radius, angle, area, and pixel intensity profile.



NIS-Elements Series of Newly Developed Imaging Software

The NIS-Elements series is used for the control software. This software allows the user to perform everything from basic image capture to the measurement, analysis, and management of captured images. Users can add a wide array of the plug-ins to basic packages according to



Accessories



Episcopic DIC (motorized nosepiece)

- 4 LV-λP λPlate
- 1
 LV-NU5AI Universal Motorized
 5
 LV-DIC Slider Position A Quintuple Nosepiece

 2
 LV-DIC Slider Position B
 6
 LV-DIC Slider Position B

 2
 LV-UPO Polarizer
 7
 LV-DIHC Slider (High Contra

 3
 LV-FLAN FL Analyzer
 8
 LV-DIHC Slider (High Contra
 CV-DIHC Slider (High Contrast) Position A
 LV-DIHC Slider (High Contrast) Position B
 CFI LU Plan Fluor EPI Objectives



Diascopic DIC (motorized nosepiece)

- 1 D-DP DIC Rotatable Polarizer 2 D-C DIC Module N1 Dry 3 D-C DIC Module N2 Dry
- 4 LV-CUD LV Universal Condenser Dry
- 5 LV-NU5AI Universal Motorized Quintuple Nosepiece 6 LV-FLAN FL Analyzer V-LP λPlate D-C DIC Slider 10x, 20x, 40xl, 100xll
 CFI Plan Fluor Objectives



Diascopic DIC (manual nosepiece)

1 D-DP DIC Rotatable Polarizer 2 D-C DIC Module N1 Dry 3 D-C DIC Module N2 Dry 4 LV-CUD LV Universal Condenser Dry

5 D-ND6 Sextuple DIC Nosepiece 6 D-DA DIC Analyzer 7 D-LP λPlate 8 D-C DIC Slider 10x, 20x, 40xl, 100xll 9 CFI Plan Fluor Objectives



Nosepiece





Diascopic Darkfield 1 LV-CUD LV Universal Condenser Dry 2 D-C Darkfield Ring



Diascopic Phase Contrast 1 LV-CUD LV Universal Condenser Dry 2 D-C DIC PH-1 Ring **O**D-C DIC PH-2 Ring

4 D-C DIC PH-3 Ring 5 CFI Plan Flour DL/DLL Objectives



Polarizing

LV-SRP Fine R Stage
 P-AMH Mechanical Stage
 P-N Centering Quintuple Nosepiece
 P-TT2 Trinocular tube
 P-CB Berek Compensator
 C-SP Simple Polarizer
 P Achromat Condenser
 P Colliptic

8 P-CL λPlate



- (B) P-CS Senarmont Compensator
- P-CQ Quartz Wedge
 <u>5 CFI LU Plan Fluor EP</u>I P Objectives



Base Unit 1 LVDIA-U DIA Base U

Specifications

	LV100DA-U	LV100D-U				
	Baseless type (a column riser can be added between the arm and stand) Maximum sample height 33mm (using the LV-NU5AI USAI nosepiece and LV-S32 3x2 stage or LV-S64 6x4 stage) / 68mm when using a column riser Integral 12V50W power supply for light adjustment Uniaxial coarse and fine refocusing handle Left: Coarse refocusing/ Right: Fine refocusing Stroke 40mm Coarse focusing 14mm per rotation (with torque adjustment and refocusing mechanism) Fine focusing 0.1mm per rotation (1µm/scale)	Baseless type (a column riser can be added between the arm and stand) Maximum sample height 38 mm (using the D-ND6 DIC nosepiece and LV-S32 3x2 stage or LV-S64 6x4 stage) / 73mm when using a column riser Integral 12V50W power supply for light adjustment Uniaxial coarse and fine focusing handle Left: Coarse focusing/ Right: Fine focusing Stroke 40mm Coarse focusing 14mm per rotation (with torque adjustment and refocusing mechanism) Fine focusing 0.1mm per rotation (1 μ m / scale)				
	Motorized nosepiece: LV-NU5AI U5AI nosepiece Episcopic illuminator: LV-UEPI2A, HG precentered fiber illuminator: C-HGFIE (PC controlled) Microscope digital camera controller: DS-L2, DS-U2 (NIS-ELEMENTS)					
	LV-NU5AI U5AI nosepiece (Heavy duty motorized universal 5-hole with anti-flare function)	D-ND6 DIC nosepiece (Universal 5-hole), L-NBD BD5 nosepiece (Bright/ darkfield 5-hole nosepiece: With anti-flare function), C-N6 nosepiece (Brightfield 6-hole), P-N6 nosepiece (Brightfield 6-hole)				
	LV-UEPI2A 12V50W high-brightness halogen lamp illuminator HG precentered fiber illuminator: C-HGFIE (with light adjustment: PC controlled) Motorized operation and control of the illumination switching turret Bright/ darkfield switching and linked motorized aperture stop (with centering: automatic optimization for the objective lens used) and field stop (with centering) ϕ 25mm filters can be inserted (NCB11, ND16, ND4) Polarizer/analyzer, λ plate, and excitation light balancer can be inserted	LV-UEPI2 12V50W high-brightness halogen lamp illuminator HG precentered fiber illuminator: C-HGFI (with light adjustment) Bright/darkfield switching and linked aperture stop (with centering) and field stop (with centering) * With a function for optimizing lighting conditions by switching among brightfield, darkfield, and epifluorescent observation ¢25mm filters can be inserted (NCB11, ND16, ND4) Polarizer/analyzer, λplate, and excitation light balancer can be inserted				
Diascopic Illuminator	12V50W high-brightness halogen lamp illuminator (Fly Eye optical system), field stop, integral filter (ND8, NCB11)					
	LV-TI3 trinocular eyepiece tube (Erected image, FOV: 22/25), LV-TT2 TT2 tilting trinocular eyepiece tube (Erected image, FOV: 22/25), Y-TB binocular lens tube (Inverted image, FOV: 22)					
Ŭ	LV-S32 3x2 stage (Stroke: 75x50 mm with glass plate) / LV-S32SGH slide glass holder / C-SRR right handle stage (Stroke: 78x54mm) C-HL 2L holder, C-HC11C holder / C-SR2 right handle stage (Stroke: 78x54 mm: Used with stage adapter LV-SAD) / LV-S64 6x4 stage (Stroke: 150x100mm with glass plate) / LV-SRP P revolving stage / P-GS2 revolving stage: Used with stage adapter LV-SAD					
Condenser	LV-CUD U Condenser Dry (brightfield, darkfield, phase contrast, DIC), LWD Achromat, Achromat 2-100 Slide, and others					
Eyepieces	CFI eyepiece series					
Objective lens	CFIeo optical system Objective lens series: Combinations in accordance with the method					
Electrostatic Decay Time	1,000 to 10V, within 0.2 sec. (excluding certain accessories)					
Power consumption	1.2A/90W	1.2A/75W				
Weight (Main Body)	Approximately 10kg	Approximately 9.5kg				

Objective Lens Chart

		Episcopic illumination						
		Brightfield	Darkfield	DIC	Polarizing	Epi-fluorescence	Double-beam interferometry	
CFI LU Plan Fluor EPI	without cover glass	0		0	🔿 Simple p	0	—	
CFI LU Plan Fluor BD		0	0	0	🔿 Simple p	0	—	
CFI LU Plan EPI P		0	—	0	0	0	—	
CF Plan EPI TI/DI*		TI/O DI/—		—	—	—	0	
CFI Plan Fluor	with cover glass	—	—	—	—	0	—	
CFI Plan Fluor DL/DLL		—	—	—	—	0	—	
CFI Plan		—	—	—	—	0	—	
CFI Plan DL		—	—	—	—	—	—	
CFI P Acromat		—	—	—	—	0	—	

		Diascopic illumination					
		Brightfield	Darkfield	Phase-contrast	Polarizing	DIC	
CFI LU Plan Fluor EPI	without	0	0	—	🔿 Simple p	<u> </u>	
CFI LU Plan Fluor BD	cover	0	0	—	\bigcirc Simple p	—	
CFI LU Plan EPI P	glass	0	0	—	0	—	
CFI Plan Fluor		0	0	—	\bigcirc Simple p	0	
CFI Plan Fluor DL/DLL	with cover glass	0	0	0	—	<u> </u>	
CFI Plan		0	0	—	—		
CFI Plan DL		0	0	0	—	<u> </u>	
CFI P Acromat		Ó	Ó	—	Ô	—	

* Parfocal distance is 45mm. A separate adapter is required.

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System Diagram

